

Notice of References Cited

Application/Control No.

10/584,472

Applicant(s)/Patent Under
Reexamination
TANAKA ET AL.

Examiner

Walter L. Lindsay, Jr.

Art Unit

2812

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0012844	01-2004	Ohtsuki et al.	359/341.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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